



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

**MARUYAMA, Shigeyuki et al.**

Group Art Unit: **2829**

Serial No.: **10/685,542**

Examiner: **Russell M. Kobert**

Filed: **October 16, 2003**

For: **SEMICONDUCTOR TESTING DEVICE**

**SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT**  
**PURSUANT TO 37 CFR 1.97(b)**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450 November 21, 2003

Sir:

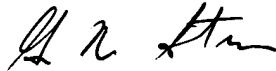
This is a Supplement Information Disclosure Statement to the Information Disclosure Statement as originally filed on October 16, 2003. In compliance with 37 CFR 1.56, Applicants call to the attention of the Patent and Trademark Office the references listed on the attached PTO-1449. The documents listed on the Form PTO-1449 were made of record in prior application Serial No. 09/828,221.

No fee or certification is required in connection with this Supplemental Information Disclosure Statement, since it is being submitted prior to the issuance of a first official action on the merits or expiration of the three month period following the filing date or the entry of the national stage of the above-captioned application.

The Commissioner is authorized to charge our Deposit Account No. 01-2340 for any fee which is deemed by the Patent and Trademark Office to be required to effect consideration of this statement.

Respectfully submitted,

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PATENT TRADEMARK OFFICE

Enclosure: PTO-1449



INFORMATION DISCLOSURE CITATION PTO-1449	Atty. Docket No. <b>990250B</b>	Serial No.: <b>10/685,542</b>
	Applicant(s): <b>MARUYAMA, Shigeyuki et al.</b>	
	Filing Date: <b>October 16, 2003</b>	Group Art Unit: <b>2829</b>

#### U.S. PATENT DOCUMENTS

Examiner Initial	Document No.	Name	Date	Class	Subclass	Filing Date (If appropriate)
	AA	5,810,609	Faraci et al.	09/22/1998	439	71
	AB	5,983,492	Fjelstad	11/16/1999	29	843
	AC	6,499,216	Fjelstad	12/31/2002	29	842
	AD	6,229,100	Fjelstad	05/08/2001	174	261
	AE	5,518,964	DiStefano et al.	05/21/1996	437	209
	AF	5,688,716	DiStefano et al.	11/18/1997	437	182
	AG	5,706,174	DiStefano et al.	01/06/1998	361	749
	AH	5,801,441	DiStefano et al.	09/01/1998	257	696
	AI	5,830,782	Smith et al.	11/03/1998	438	123
	AJ	5,913,109	DiStefano et al.	06/15/1999	438	117
	AK	5,959,354	Smith et al.	09/28/1999	257	734
	AL	5,989,936	Smith et al.	11/23/1999	438	106
	AM	6,012,224	DiStefano et al.	01/11/2000	29	840
	AN	6,080,603	DiStefano et al.	06/27/2000	438	117

#### FOREIGN PATENT DOCUMENTS

Document No.	Date	Country	Translation (Yes or No)
AO 8-31888	02/02/1996	Japan	Abstract
AP 10-256314	09/25/1998	Japan	Abstract

#### OTHER DOCUMENTS

AQ	Notice of Reasons of Rejection issued April 30, 2002 by the Japan Patent Office w/ the partial translation
Examiner	Date Considered